

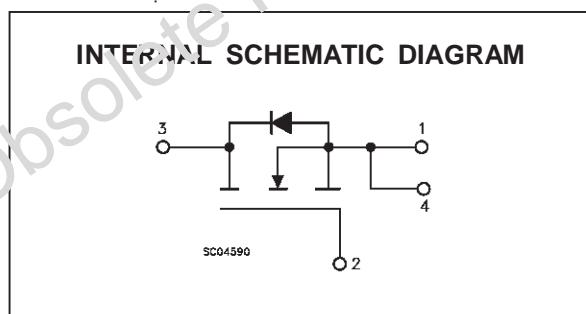
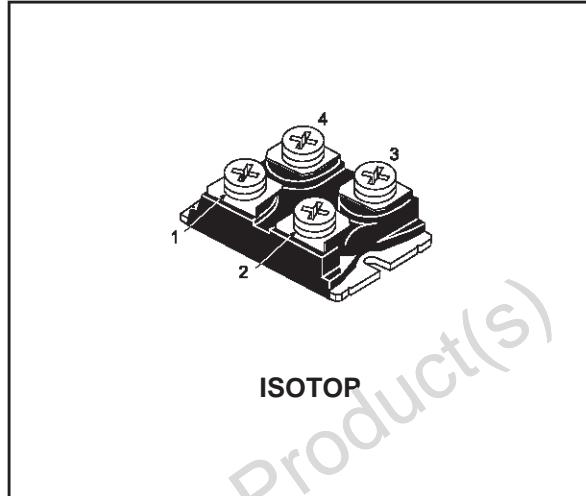
**STE26NA90****N - CHANNEL 900V - 0.25Ω - 26A - ISOTOP  
FAST POWER MOSFET**

| TYPE      | V <sub>DSS</sub> | R <sub>D(on)</sub> | I <sub>D</sub> |
|-----------|------------------|--------------------|----------------|
| STE26NA90 | 900 V            | < 0.3 Ω            | 26 A           |

- TYPICAL R<sub>D(on)</sub> = 0.25 Ω
- ± 30V GATE TO SOURCE VOLTAGE RATING
- 100% AVALANCHE TESTED
- LOW INTRINSIC CAPACITANCE
- GATE CHARGE MINIMIZED
- REDUCED VOLTAGE SPREAD

**APPLICATIONS**

- HIGH CURRENT, HIGH SPEED SWITCHING
- SWITCH MODE POWER SUPPLY (SMPS)
- DC-AC CONVERTER FOR WELDING EQUIPMENT AND UNINTERRUPTABLE POWER SUPPLY AND MOTOR DRIVE

**ABSOLUTE MAXIMUM RATINGS**

| Symbol             | Parameter   | Value      | Unit |
|--------------------|---|------------|------|
| V <sub>DS</sub>    | Drain-source Voltage (V <sub>GS</sub> = 0)            | 900        | V    |
| V <sub>DG</sub>    | Drain-gate Voltage (R <sub>GS</sub> = 20 kΩ)          | 900        | V    |
| V <sub>GS</sub>    | Gate-source Voltage                                   | ± 30       | V    |
| I <sub>D</sub>     | Drain Current (continuous) at T <sub>c</sub> = 25 °C  | 26         | A    |
| I <sub>D</sub>     | Drain Current (continuous) at T <sub>c</sub> = 100 °C | 16.2       | A    |
| I <sub>DM(•)</sub> | Drain Current (pulsed)                                | 104        | A    |
| P <sub>tot</sub>   | Total Dissipation at T <sub>c</sub> = 25 °C           | 450        | W    |
|                    | Derating Factor                                       | 3.6        | W/°C |
| T <sub>stg</sub>   | Storage Temperature                                   | -55 to 150 | °C   |
| T <sub>j</sub>     | Max. Operating Junction Temperature                   | 150        | °C   |
| V <sub>ISO</sub>   | Insulation Withstand Voltage (AC-RMS)                 | 2500       | V    |

(•) Pulse width limited by safe operating area

## STE26NA90

### THERMAL DATA

|                |   |     |      |                             |
|----------------|---|-----|------|-----------------------------|
| $R_{thj-case}$ | Thermal Resistance Junction-case                                | Max | 0.27 | $^{\circ}\text{C}/\text{W}$ |
| $R_{thc-h}$    | Thermal Resistance Case-heatsink With Conductive Grease Applied | Max | 0.05 | $^{\circ}\text{C}/\text{W}$ |

### AVALANCHE CHARACTERISTICS

| Symbol          | Parameter  | Max Value | Unit |
|-----------------|--|-----------|------|
| $I_{\text{AR}}$ | Avalanche Current, Repetitive or Not-Repetitive (pulse width limited by $T_j$ max)                                   | 13        | A    |
| $E_{\text{AS}}$ | Single Pulse Avalanche Energy (starting $T_j = 25^{\circ}\text{C}$ , $I_D = I_{\text{AR}}$ , $V_{\text{DD}} = 50$ V) | 3000      | mJ   |

### ELECTRICAL CHARACTERISTICS ( $T_{\text{case}} = 25^{\circ}\text{C}$ unless otherwise specified)

OFF

| Symbol                      | Parameter  | Test Conditions  | Min. | Typ. | Max.        | Unit                           |
|-----------------------------|--|--|------|------|-------------|--------------------------------|
| $V_{(\text{BR})\text{DSS}}$ | Drain-source Breakdown Voltage                   | $I_D = 500 \mu\text{A}$ $V_{GS} = 0$   | 900  |      |             | V                              |
| $I_{\text{DSS}}$            | Zero Gate Voltage Drain Current ( $V_{GS} = 0$ ) | $V_{DS} = \text{Max Rating}$<br>$V_{DS} = \text{Max Rating}$ $T_c = 125^{\circ}\text{C}$ |      |      | 250<br>1000 | $\mu\text{A}$<br>$\mu\text{A}$ |
| $I_{GSS}$                   | Gate-body Leakage Current ( $V_{DS} = 0$ )       | $V_{GS} = \pm 30$ V  |      |      | $\pm 200$   | nA                             |

ON (\*)

| Symbol              | Parameter                         | Test Conditions   | Min. | Typ. | Max. | Unit     |
|---------------------|-----------------------------------|---|------|------|------|----------|
| $V_{GS(\text{th})}$ | Gate Threshold Voltage            | $V_{DS} = V_{GS}$ $I_D = 1$ mA  | 2.25 | 3    | 3.75 | V        |
| $R_{DS(\text{on})}$ | Static Drain-source On Resistance | $V_{GS} = 10$ V $I_D = 13$ A  |      | 0.25 | 0.3  | $\Omega$ |
| $I_{D(\text{on})}$  | On State Drain Current            | $V_{DS} > I_{D(\text{on})} \times R_{DS(\text{on})\text{max}}$<br>$V_{GS} = 10$ V | 26   |      |      | A        |

### DYNAMIC

| Symbol                              | Parameter   | Test Conditions   | Min. | Typ.                 | Max.                 | Unit           |
|-------------------------------------|---|---|------|----------------------|----------------------|----------------|
| $g_{fs}$ (*)                        | Forward Transconductance  | $V_{DS} > I_{D(\text{on})} \times R_{DS(\text{on})\text{max}}$ $I_D = 13$ A | 15   |                      |                      | S              |
| $C_{iss}$<br>$C_{oss}$<br>$C_{rss}$ | Input Capacitance<br>Output Capacitance<br>Reverse Transfer Capacitance | $V_{DS} = 25$ V $f = 1$ MHz $V_{GS} = 0$                                    |      | 13600<br>1130<br>270 | 17700<br>1470<br>350 | pF<br>pF<br>pF |

**ELECTRICAL CHARACTERISTICS (continued)**

## SWITCHING ON

| Symbol                        | Parameter  | Test Conditions   | Min. | Typ.             | Max.     | Unit           |
|-------------------------------|--|---|------|------------------|----------|----------------|
| $t_{d(on)}$<br>$t_r$          | Turn-on Time<br>Rise Time                                    | $V_{DD} = 450 \text{ V}$ $I_D = 12 \text{ A}$<br>$R_G = 4.7 \Omega$ $V_{GS} = 10 \text{ V}$<br>(see test circuit, figure 3) |      | 40<br>52         | 56<br>73 | ns<br>ns       |
| $Q_g$<br>$Q_{gs}$<br>$Q_{gd}$ | Total Gate Charge<br>Gate-Source Charge<br>Gate-Drain Charge | $V_{DD} = 720 \text{ V}$ $I_D = 26 \text{ A}$ $V_{GS} = 10 \text{ V}$   |      | 470<br>43<br>226 | 660      | nC<br>nC<br>nC |

## SWITCHING OFF

| Symbol                             | Parameter   | Test Conditions   | Min. | Typ.             | Max.             | Unit           |
|------------------------------------|---|---|------|------------------|------------------|----------------|
| $t_{r(V_{off})}$<br>$t_f$<br>$t_c$ | Off-voltage Rise Time<br>Fall Time<br>Cross-over Time | $V_{DD} = 720 \text{ V}$ $I_D = 26 \text{ A}$<br>$R_G = 4.7 \Omega$ $V_{GS} = 10 \text{ V}$<br>(see test circuit, figure 5) |      | 108<br>25<br>145 | 152<br>35<br>203 | ns<br>ns<br>ns |

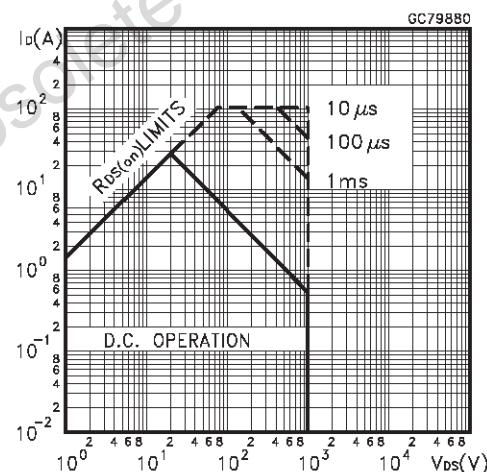
## SOURCE DRAIN DIODE

| Symbol                            | Parameter   | Test Conditions   | Min. | Typ.            | Max.      | Unit                                |
|-----------------------------------|---|---|------|-----------------|-----------|-------------------------------------|
| $I_{SD}$<br>$I_{SDM}(\bullet)$    | Source-drain Current<br>Source-drain Current<br>(pulsed)                              |   |      |                 | 26<br>104 | A<br>A                              |
| $V_{SD} (\ast)$                   | Forward On Voltage  | $I_{SD} = 26 \text{ A}$ $V_{GS} = 0$  |      |                 | 1.6       | V                                   |
| $t_{rr}$<br>$Q_{rr}$<br>$I_{RRM}$ | Reverse Recovery<br>Time<br>Reverse Recovery<br>Charge<br>Reverse Recovery<br>Current | $I_{SD} = 26 \text{ A}$ $di/dt = 100 \text{ A}/\mu\text{s}$<br>$V_{DD} = 100 \text{ V}$ $T_j = 150^\circ\text{C}$<br>(see test circuit, figure 5) |      | 1.3<br>38<br>58 |           | $\mu\text{s}$<br>$\mu\text{C}$<br>A |

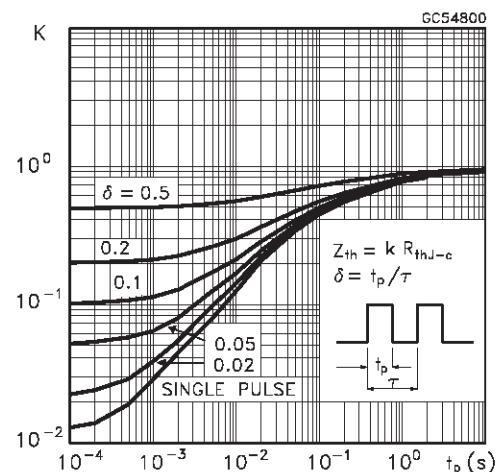
(\*) Pulsed: Pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5 %

(\*) Pulse width limited by safe operating area

## Safe Operating Area

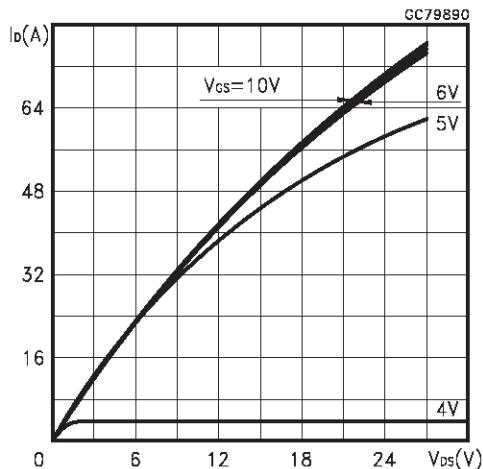


## Thermal Impedance

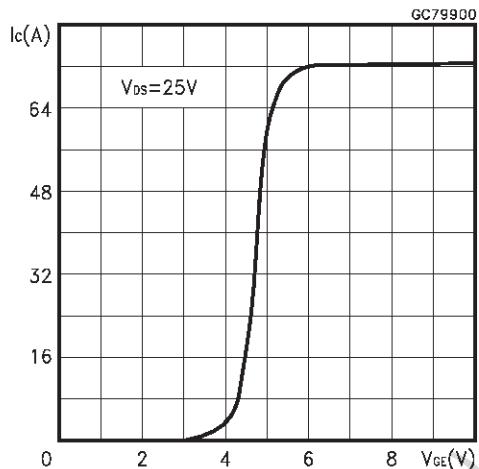


## STE26NA90

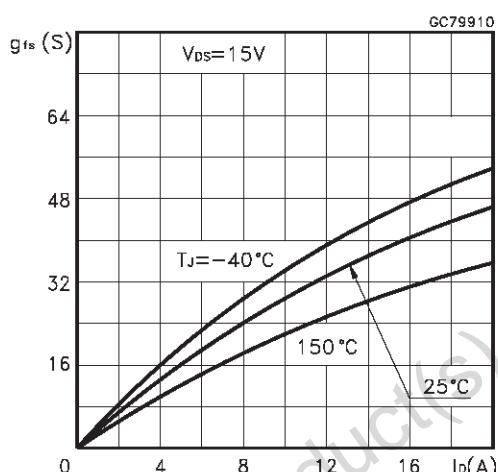
### Output Characteristics



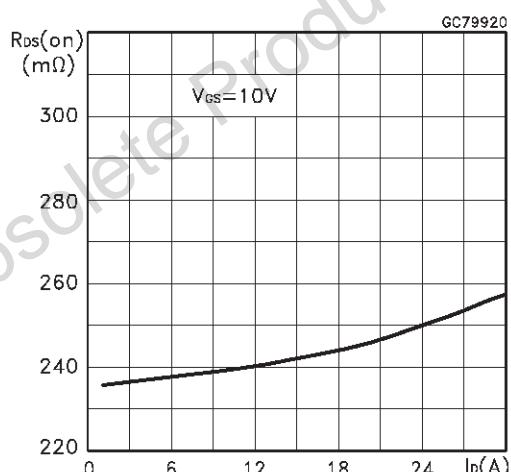
### Transfer Characteristics



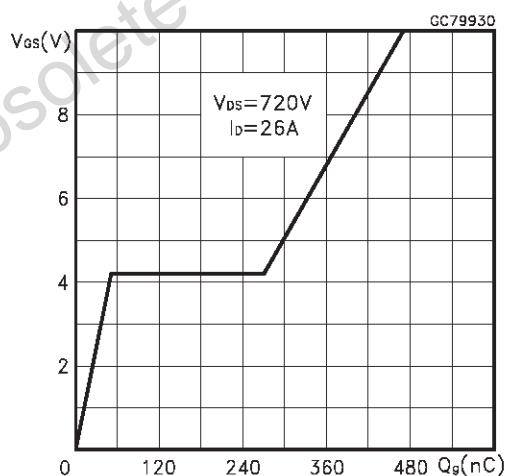
### Transconductance



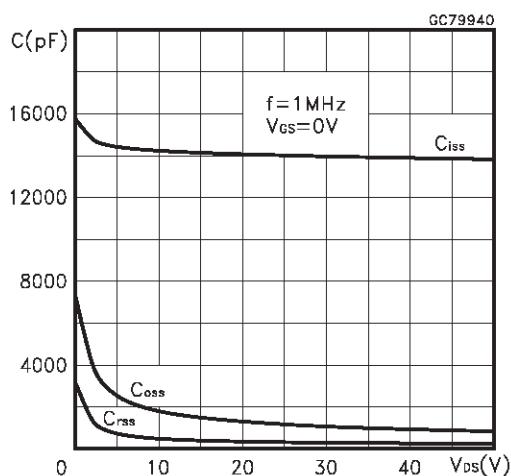
### Static Drain-source On Resistance



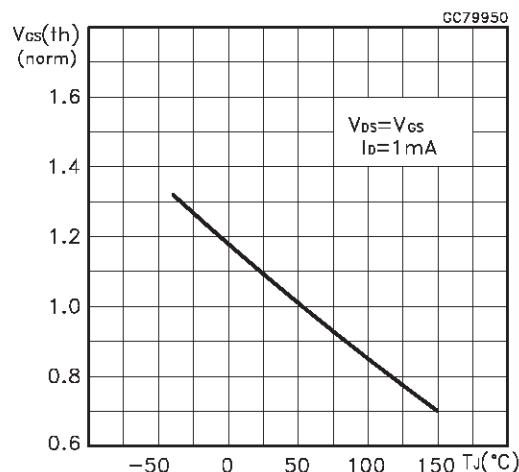
### Gate Charge vs Gate-source Voltage



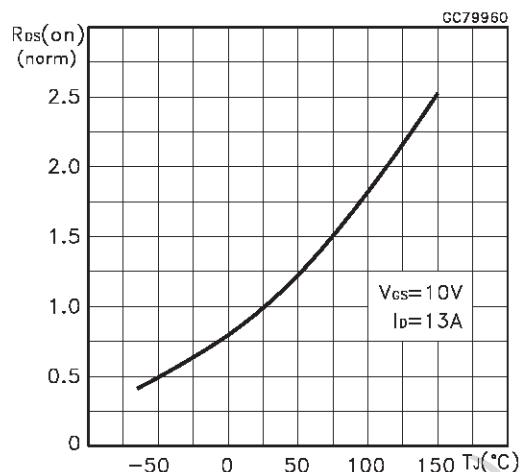
### Capacitance Variations



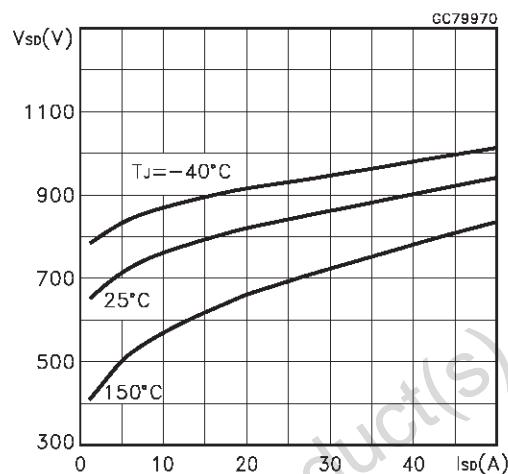
Normalized Gate Threshold Voltage vs Temperature



Normalized On Resistance vs Temperature

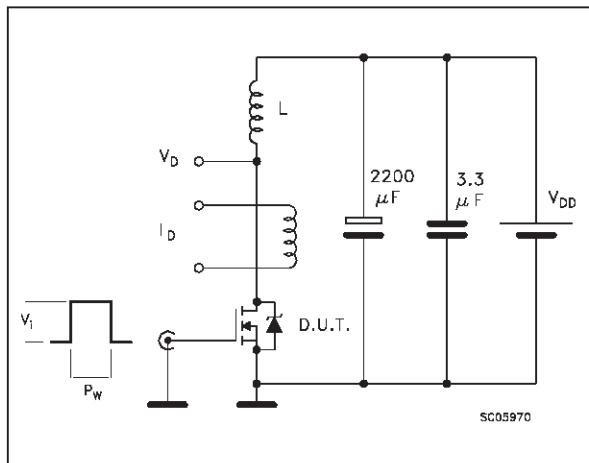


Source-drain Diode Forward Characteristics

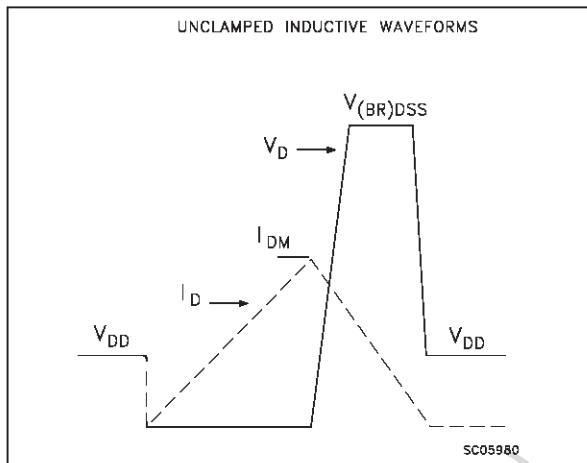


## STE26NA90

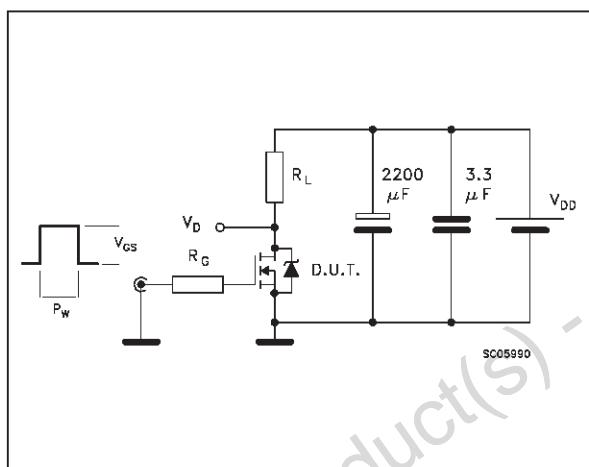
**Fig. 1:** Unclamped Inductive Load Test Circuit



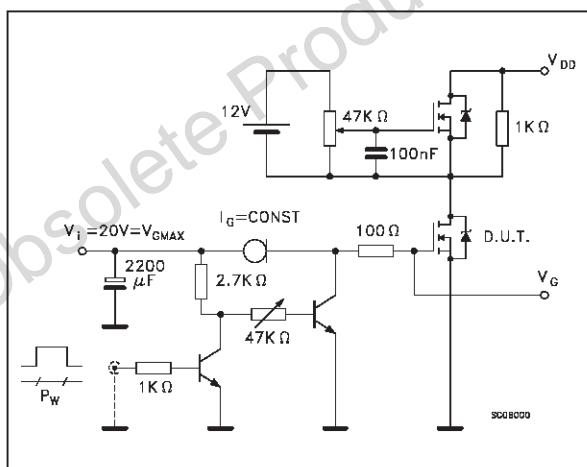
**Fig. 2:** Unclamped Inductive Waveform



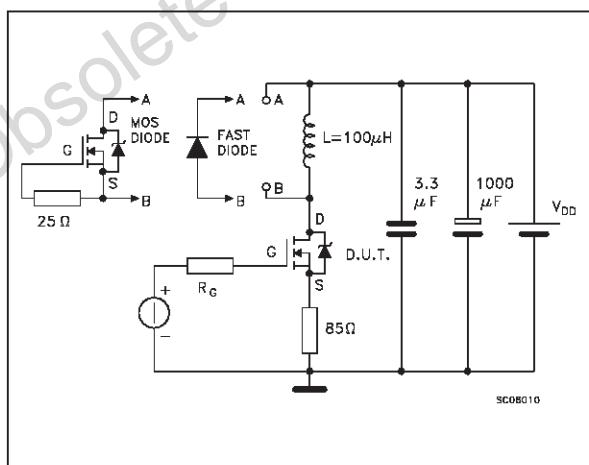
**Fig. 3:** Switching Times Test Circuits For Resistive Load



**Fig. 4:** Gate Charge test Circuit

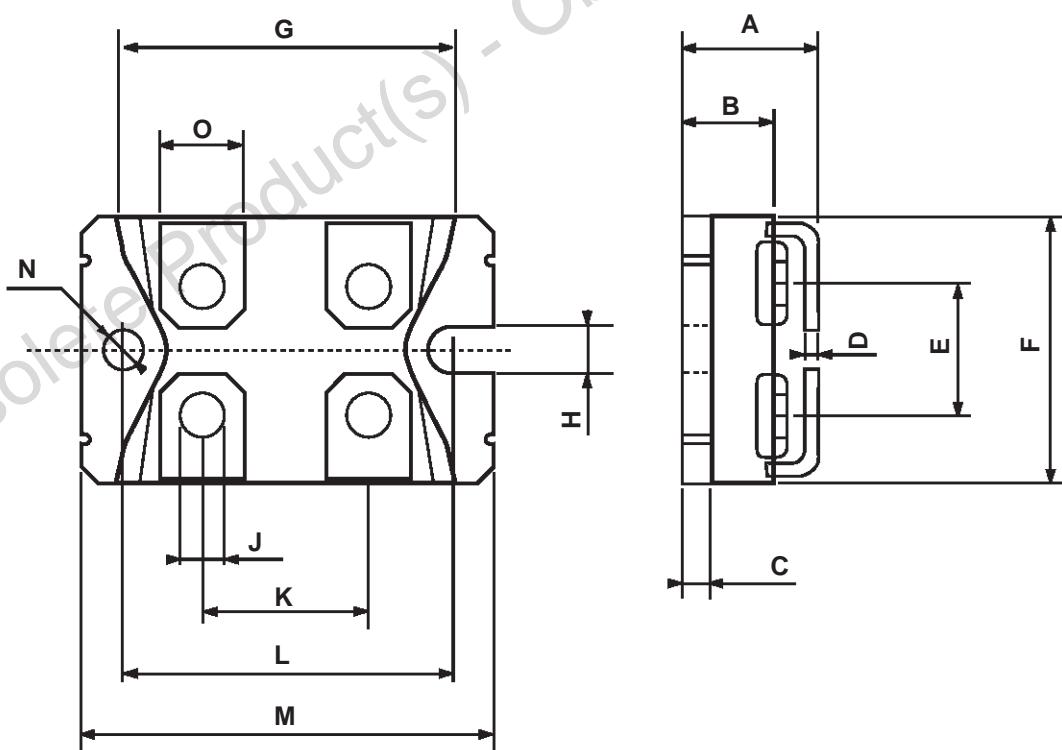


**Fig. 5:** Test Circuit For Inductive Load Switching And Diode Recovery Times



## ISOTOP MECHANICAL DATA

| DIM. | mm    |      |      | inch  |      |       |
|------|-------|------|------|-------|------|-------|
|      | MIN.  | TYP. | MAX. | MIN.  | TYP. | MAX.  |
| A    | 11.8  |      | 12.2 | 0.466 |      | 0.480 |
| B    | 8.9   |      | 9.1  | 0.350 |      | 0.358 |
| C    | 1.95  |      | 2.05 | 0.076 |      | 0.080 |
| D    | 0.75  |      | 0.85 | 0.029 |      | 0.033 |
| E    | 12.6  |      | 12.8 | 0.496 |      | 0.503 |
| F    | 25.15 |      | 25.5 | 0.990 |      | 1.003 |
| G    | 31.5  |      | 31.7 | 1.240 |      | 1.248 |
| H    | 4     |      |      | 0.157 |      |       |
| J    | 4.1   |      | 4.3  | 0.161 |      | 0.169 |
| K    | 14.9  |      | 15.1 | 0.586 |      | 0.594 |
| L    | 30.1  |      | 30.3 | 1.185 |      | 1.193 |
| M    | 37.8  |      | 38.2 | 1.488 |      | 1.503 |
| N    | 4     |      |      | 0.157 |      |       |
| O    | 7.8   |      | 8.2  | 0.307 |      | 0.322 |



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